Appl. no. 10/715,683 IDS dated October 7, 2005

Modified Form PTO/SB/08A

Substitute	for form 1449A/P	m		Co	mplete If Known
		-		Application Number	10/715,683
	RMATION			Filing Date	November 17, 2003
STATEMENT BY APPLICANT				First Named Inventor	Gaetan L. Mathieu et al.
(u	se as many shee	ts as necessa	ury)	Group Art Unit	7298
				Examiner Name	Neil Abrams
Sheet	1	of	2	Attorncy Docket No.	P75D1-US (12439.176)

		U.S. I	PUBLIS	HED PATENT DOCUME	NTS		······································
Examiner	Citc	U.S. Patent Document		Name of Patentee or	Publ/Issue	Related	Сору
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^{*} EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-latter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁴Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁴Applicant is to place a check mark here if English language Translation is attached.

^{**} Reference cited in parent application US Serial No. 09/473,414, now US Palent No. 6,827,584 B2. 37 CFR § 1.98(d)

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[#] Commonly owned US patent or application whose subject matter may be related to the subject matter of the instance patent application.

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(usc as many sheets as necessary)			y)	Group Art Unit	7298	
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Sheet	2	of	2	Attorncy Docket No.	P75D1-US (12439.176)	

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M	33.	WEAST, "Handbook of Chemistry and Physics," pp. D-171 and D-172 (CRC Press).		No				

Examiner	7	α	Date	_
Signature		- Clorun	Considered	12-23-05

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